

**Search Notes**

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Examiner

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MINAMIO ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	59, 72, 431-434, 460, 462	9/6/2006	TT

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search history printout	9/6/2006	TT